


<p style="text-align: center;">Search Notes</p> 	<p>Application/Control No.</p> <p>09945408</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>KOHNO ET AL.</p>
	<p>Examiner</p> <p>DEVONA E FAULK</p>	<p>Art Unit</p> <p>2615</p>

SEARCHED			
Class	Subclass	Date	Examiner
381	119	2/2/05	
369	4	2/2/05	DEF
84	625,660	3/2/05, 6/22/05	DEF
700	94	2/13/05	DEF
381	119	6/21/06	DEF
369	4	6/21/06	DEF
84	625,609,610	6/21/06	DEF
700	94	6/21/06	DEF
381	119	4/3/07	DEF
84	600-602,615	4/5/07	DEF
381	119	12/5/07	DEF
84	660	12/5/07	DEF
381	119	7/14/08	DEF
369	4	7/14/08	DEF
84	600-602,615,625,660	7/14/08	DEF
710	67,73	7/14/08	DEF
381	119	1/29/09	DEF
700	94	1/29/09	DEF
84	600-609,615,660	1/29/09	DEF

SEARCH NOTES		
Search Notes	Date	Examiner
Assignee/Inventor	2/11/05	DEF
combined class/word search with 381, 600/94, 84/600-606,609,610,622,625,660	3/1,3/05, 4/23/05, 6/27/05	DEF
consulted with Marlon Fletcher of class 84	6/8/05	DEF
word search	6/21/06	DEF
additional search	4/4,5/07, 5/15/07, 7/24,25/07	DEF
additional search	8/5/07	DEF
consulted with Marlon Fletcher	4/5/07	DEF
Additional search	12/5/07, 1/23,28,29/08	DEF
additional search	2/3/08, 7/14/08	DEF

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SEARCH NOTES		
Search Notes	Date	Examiner
additional search	7/28,29/08	DEF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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